

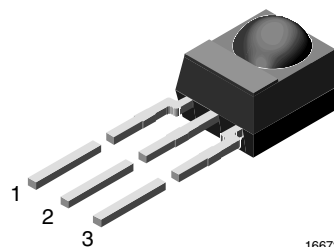
IR Receiver for High Data Rate PCM at 455 kHz

Description

The TSOP7000 is a miniaturized receiver for infrared remote control and IR data transmission. PIN diode and preamplifier are assembled on lead frame, the epoxy package is designed as IR filter.

The demodulated output signal can directly be decoded by a microprocessor. The main benefit is the operation with high data rates and long distances.

This component has not been qualified according to automotive specifications.



Features

- Photo detector and preamplifier in one package
- Internal Bandfilter for PCM frequency
- Internal shielding against electrical field disturbance
- TTL and CMOS compatibility
- Output active low
- Small size package
- Lead (Pb)-free component
- Component in accordance to RoHS 2002/95/EC and WEEE 2002/96/EC



Special Features

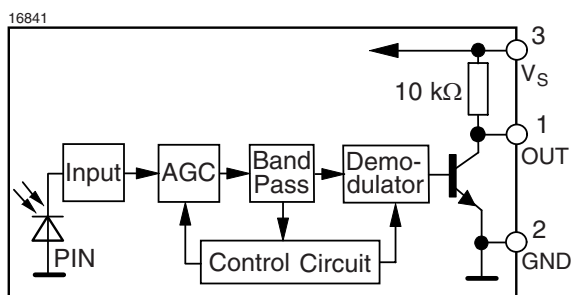
- Data rate 20 kbit/s
- Supply voltage 2.7 - 5.5 V
- Short settling time after power on
- High envelope duty cycle can be received
- Enhanced immunity against disturbance from energy saving lamps

Mechanical Data

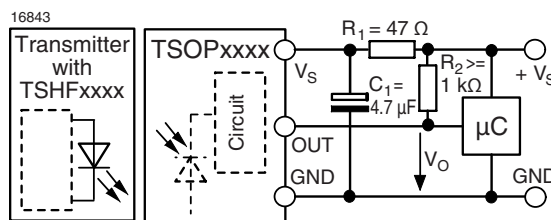
Pinning:

1 = OUT, 2 = GND, 3 = V_S

Block Diagram



Application Circuit



$R_1 + C_1$ recommended to suppress power supply disturbances.

R_2 optional for improved pulse forming.

**Absolute Maximum Ratings** $T_{amb} = 25\text{ }^{\circ}\text{C}$, unless otherwise specified

Parameter	Test condition	Symbol	Value	Unit
Supply Voltage	Pin 3	V_S	-0.3 to + 6.0	V
Voltage at output to supply	Pin 1	$V_S - V_O$	-0.3 to ($V_S + 0.3$)	V
Supply Current	Pin 3	I_S	5	mA
Output Voltage	Pin 1	V_O	-0.3 to + 6.0	V
Output Current	Pin 1	I_O	15	mA
Junction Temperature		T_j	100	$^{\circ}\text{C}$
Storage Temperature Range		T_{stg}	- 25 to + 85	$^{\circ}\text{C}$
Operating Temperature Range		T_{amb}	- 25 to + 85	$^{\circ}\text{C}$
Soldering Temperature	$t \leq 10\text{ s}$, 1 mm from case	T_{sd}	260	$^{\circ}\text{C}$
Power Consumption		P_{tot}	30	mW

Electrical and Optical Characteristics $T_{amb} = 25\text{ }^{\circ}\text{C}$, unless otherwise specified

Parameter	Test condition	Symbol	Min	Typ.	Max	Unit
Supply Current (Pin 3)	Dark ambient	I_{SD}		2.0	2.7	mA
	$E_v = 40\text{ klx}$, sunlight	I_{SH}		2.3		mA
Supply Voltage (Pin 3)		V_S	2.7	5	5.5	V
Transmission Distance	$\lambda_p = 870\text{ nm}$, IR Diode TSHF5400, $I_F = 300\text{ mA}$	d_{max}		20		m
	$\lambda_p = 950\text{ nm}$, IR Diode TSAL6400, $I_F = 300\text{ mA}$	d_{max}		12		m
Threshold Irradiance	$\lambda_p = 870\text{ nm}$, optical test signal of fig. 1	$E_{e\ min}$		0.8	1.5	mW/m^2
Maximum Irradiance	Optical test signal of fig. 1	$E_{e\ max}$	30			W/m^2
Output Voltage Low (Pin 1)	1 $\text{k}\Omega$ external pull up resistor	V_{QL}			100	mV
Output Voltage High (Pin 1)	No external pull-up resistor	V_{QH}	$V_S - 0.25$			V
Bandpass filter quality		Q		10		
Out-Pulse width tolerance	Optical test signal of fig. 1, $1.5\text{ mW}/\text{m}^2 \leq E_e \leq 30\text{ W}/\text{m}^2$	Δt_{po}	- 15	+ 5	+ 15	μs
Delay time of output pulse	Optical test signal of fig. 1, $E_e > 1.5\text{ mW}/\text{m}^2$	t_{don}	15		36	μs
Receiver start up time	Valid data after power on	t_V		50		μs
Falling time	Leading edge of output pulse	t_f		0.4		μs
Rise time	No external pull up resistor	t_r		12		μs
	1 $\text{k}\Omega$ external pull up resistor	t_r		1.2		μs
Directivity	Angle of half transmission distance	$\Phi_{1/2}$		± 45		deg

Typical Characteristics

$T_{amb} = 25\text{ }^{\circ}\text{C}$, unless otherwise specified

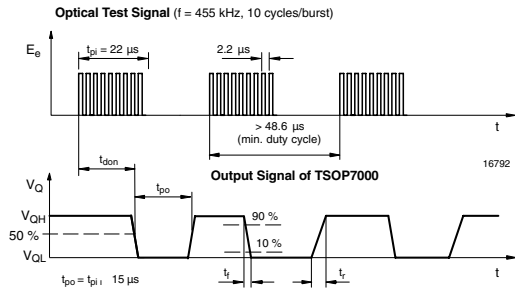


Figure 1. Output Function

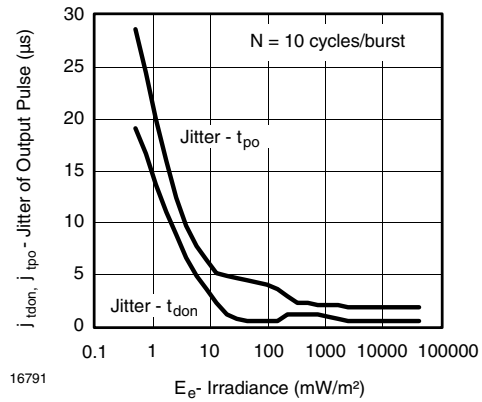


Figure 4. Jitter of Output Pulse

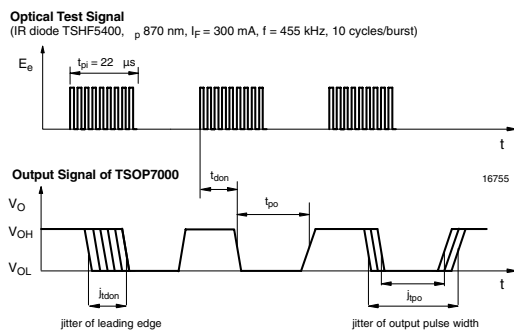


Figure 2. Output Function (mit Jitter)

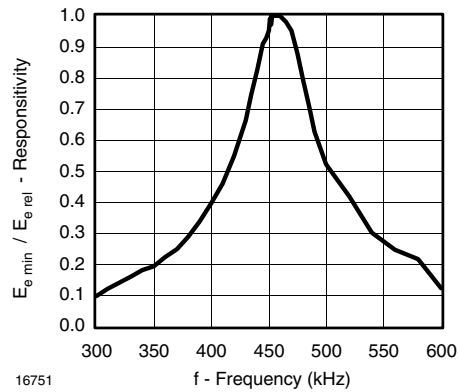


Figure 5. Frequency Dependence of Responsivity

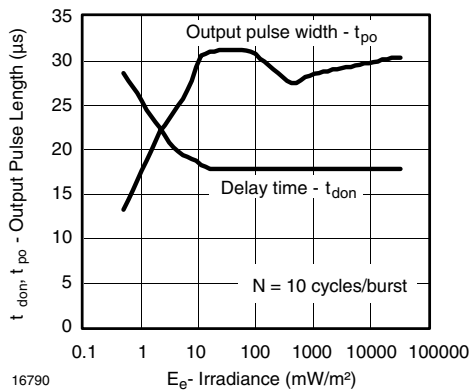


Figure 3. Output Pulse Diagram (t_{don} , t_{po})

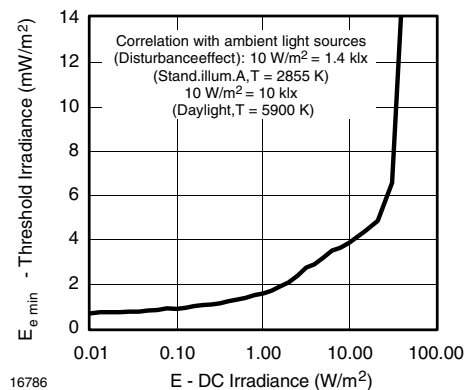


Figure 6. Sensitivity in Bright Ambient

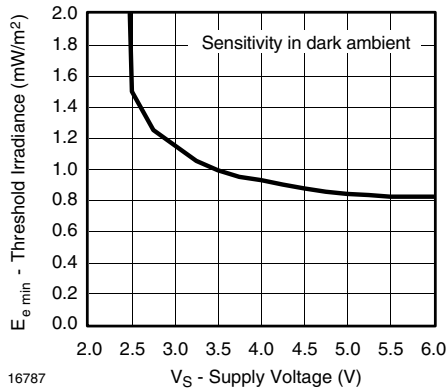


Figure 7. Sensitivity vs. Supply Voltage

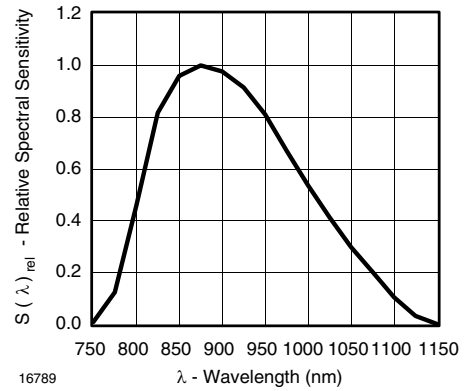


Figure 10. Relative Spectral Sensitivity vs. Wavelength

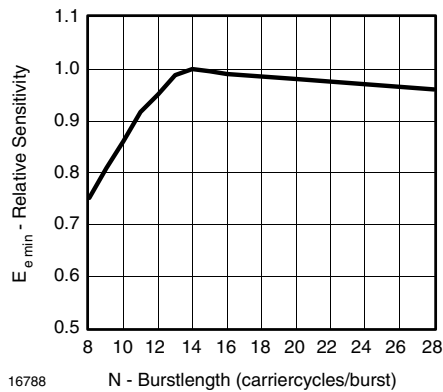


Figure 8. Rel. Sensitivity vs. Burstlength

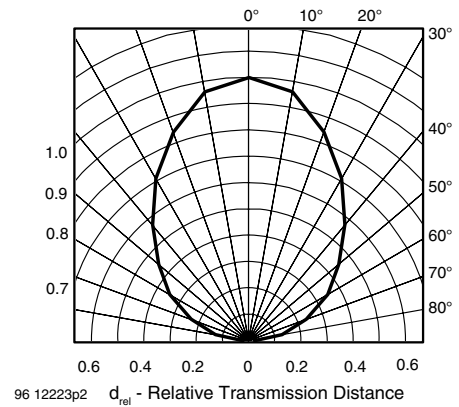


Figure 11. Directivity

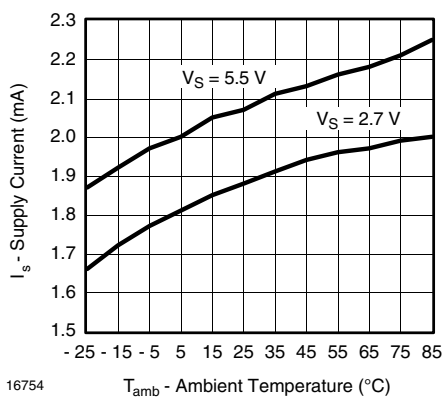


Figure 9. Supply Current vs. Ambient Temperature



Ozone Depleting Substances Policy Statement

It is the policy of Vishay Semiconductor GmbH to

1. Meet all present and future national and international statutory requirements.
2. Regularly and continuously improve the performance of our products, processes, distribution and operating systems with respect to their impact on the health and safety of our employees and the public, as well as their impact on the environment.

It is particular concern to control or eliminate releases of those substances into the atmosphere which are known as ozone depleting substances (ODSs).

The Montreal Protocol (1987) and its London Amendments (1990) intend to severely restrict the use of ODSs and forbid their use within the next ten years. Various national and international initiatives are pressing for an earlier ban on these substances.

Vishay Semiconductor GmbH has been able to use its policy of continuous improvements to eliminate the use of ODSs listed in the following documents.

1. Annex A, B and list of transitional substances of the Montreal Protocol and the London Amendments respectively
2. Class I and II ozone depleting substances in the Clean Air Act Amendments of 1990 by the Environmental Protection Agency (EPA) in the USA
3. Council Decision 88/540/EEC and 91/690/EEC Annex A, B and C (transitional substances) respectively.

Vishay Semiconductor GmbH can certify that our semiconductors are not manufactured with ozone depleting substances and do not contain such substances.

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and may do so without further notice.

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